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| APPLICATION NO. | FILING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO. |
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| 10/600,626 | 06/20/2003 | Archer Lawrence | KIN03003 | 7189 |
| 33438 | 7590 | 06/06/2005 | EXAMINER | |
| HAMILTON & TERRILE, LLP | | | PRETLOW, DEMETRIUS R | |
| P.O. BOX 203518 | | | ART UNIT | |
| AUSTIN, TX 78720 | | | PAPER NUMBER | |
| | | | 2863 | |
| DATE MAILED: 06/06/2005 | | | | |

Please find below and/or attached an Office communication concerning this application or proceeding.

AK

Office Action Summary

Application No.

10/600,626

Applicant(s)

LAWRENCE ET AL.

Examiner

Demetrius R. Pretlow

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 17 March 2005.
- 2a) ☐ This action is FINAL. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1,3-10 and 12-17 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☒ Claim(s) 6-10 and 12-17 is/are allowed.
- 6) ☐ Claim(s) 1 and 5 is/are rejected.
- 7) ☒ Claim(s) 3 is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 20 June 2003 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date _____
- 4) ☐ Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____

DETAILED ACTION

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claims 1, 4 and 5 are rejected under 35 U.S.C. 103(a) as being unpatentable over WU 5,831,992. in view of Sundermann (US 5,899,961). In reference to claim 1, Wu teach a tester (12) operable to generate test data and apply the test data to the electronic device to determine the response of the electronic device; Note Wu column 3, lines 53-58. Wu teach a capture interface operable to capture the test data communicated to the electronic device by the tester; (performed by the self test of the integrated circuit) Note Wu column 4, lines 6, 7 and 12. Wu teach a compression engine (14) in communication with the capture interface and operable to compress the test data; Note column 4, lines 12-14 and lines 48-54. Wu teach a memory in communication with the compression engine and operable to save the compressed test data. Note Wu column 4, lines 26-28.

Wu does not teach a de-compression engine interfaced with the memory and operable to de-compress the test data:

Sundermann teach de-compression engine (sequencer) interfaced with the memory (Note column 2, line 56-58 and column 5, lines 54-56) and operable to de-compress the test data (data sequence) : Note : Note column 2, lines 65-66.

It would have been obvious to a person of ordinary skill in the art at the time the invention was made to modify the invention of Wu to include the teaching of Sundermann because it would allow the decompressed data sequence to be compared to a response signal at the respective pin of the device under test. Note Sundermann column 2, lines 65-66 and column 3, lines 3-5.

Wu does not teach an analyzer interfaced with the de-compression engine and operable to analyze the de-compressed test data to determine the test data source of an electronic device error response.

Sundermann teach an analyzer interfaced with the de-compression engine and operable to analyze the de-compressed test data to determine the test data source of an electronic device error response. Note Sundermann column 6, lines 14-21.

It would have been obvious to a person of ordinary skill in the art at the time the invention was made to modify the invention of Wu to include the teaching of Sundermann because it would allow which bits at the same place of those sequences were the same and which bits were not the same to be written into the error memory. Note Sundermann column 6, lines 19-21.

In reference to claim 4, Wu teach the tester is further operable to run the test program on production electronic devices (CUT) to detect the error response. Note column 3, lines 58-60.

In reference to claim 5, Wu teach a vector generator operable to generate vector test data. Note column 4, lines 43-46.

Claim Objections

Claim 3 is objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims. The prior art of record particular WU 5,831,992 does not teach the following claim limitations wherein the test data comprises plural cycles including empty cycles not associated with the electronic device error response, and wherein the analyzer is further operable to generate a test program that reduces the empty cycles of the test data.

Allowable Subject Matter

Claims 6-10,12-17 allowed.

The primary reason for the allowance of claims 6-8 is the inclusion of the limitations of an a memory device operable to store data fields according to address and control information and the vector generator generates memory vectors for storage on the memory device.

It is these limitations found in each of the claims, as they are claimed in the combination, that has not been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.

The primary reason for the allowance of claim 9 is the inclusion of the limitations of an wherein the memory further comprises plural memory motherboards; a memory

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parser associated with each memory motherboard; plural memory controllers associated with each memory parser; and plural memory storage devices associated with each memory controller; wherein the memory parser coordinates with its associated memory controllers to store test data on plural memory storage devices in sequence so that the memory storage devices operate on a lower clock speed than the test data generation clock speed. It is these limitations found in each of the claims, as they are claimed in the combination, that has not been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.

The primary reason for the allowance of claims 10,12-14 is the inclusion of the method step of wherein the electronic device comprises a memory device and generating test data further comprises generating vectors of memory test data for storage on the memory device, the memory test data having data field, address and control information. It is this steps found in each of the claims, as it is **claimed in the combination**, that has not been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.

The primary reason for the allowance of claim 15 is the inclusion of the method step of wherein storing the compressed test data further comprises coordinating storage of the test data in plural storage devices so that the storage devices operate at a slower clock speed than the clock speed associated with the generation of the test data. It is this step found in each of the claims, as it is **claimed in the combination**, that has not

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been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.

The primary reason for the allowance of claims 16 and 17 is the inclusion of the method steps of de-compressing the compressed test data to replay the test data applied to the electronic device; and passing the replayed test data through a logic analyzer to determine the applied test data that generated an error response. It is these steps found in each of the claims, as it is **claimed in the combination**, that has not been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Demetrius R. Pretlow whose telephone number is (571) 272-2278. The examiner can normally be reached on Mon.-Fri. 8-4:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Barlow can be reached on (571) 272-2269. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Demetrius R. Pretlow

Demetrius Pretlow 6/1/05

Patent Examiner

BRYAN BUI
PRIMARY EXAMINER

Bryan Bui